

SIGC57T120R3L

IGBT³ Chip

FEATURES:

- 1200V Trench + Field Stop technology
- 120µm chip
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

This chip is used for:

power module



Applications:

drives

Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC57T120R3L	1200V	50A	7.6 x 7.53 mm ²	sawn on foil	Q67050- A4267-A101

MECHANICAL PARAMETER:

Raster size	7.6 x 7.53	mm		
Emitter pad size (include gate pad)	6.08 x 6.05			
Gate pad size	1.14 x 1.14			
Area total / active	57.2 / 42.8	mm ²		
Thickness	120	μm		
Wafer size	150	mm		
Flat position	90	grd		
Max.possible chips per wafer	246 pcs			
Passivation frontside	Photoimide			
Emitter metallization	3200 nm AlSiCu			
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond	Al, <500μm			
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			



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MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T _j =25 °C	V _{CE}	1200	V
DC collector current, limited by T _{jmax}	I _C	1)	А
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	150	Α
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 + 150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
- urumeter	Cymbol		min.	typ.	max.	O
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0 V , I_{C} = 2 mA	1200			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =50A	1.35	1.65	2.05	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	I _C =2mA , V _{GE} =V _{CE}	5.0	5.8	6.5	
Zero gate voltage collector current	I _{CES}	V _{CE} =1200V , V _{GE} =0V			6.69	μA
Gate-emitter leakage current	I _{GES}	V _{CE} =0V , V _{GE} =20V			600	nA
Integrated gate resistor	R _{Gint}			4		Ω

ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol Conditions	Value			Unit	
raiailietei	Symbol	Conditions	min.	typ.	max.	Oiiit
Input capacitance	Ciss	V _{CE} =25V,		3600		pF
Output capacitance	Coss	$V_{GE}=0V$,		188		
Reverse transfer capacitance	Crss	f=1MHz		163		

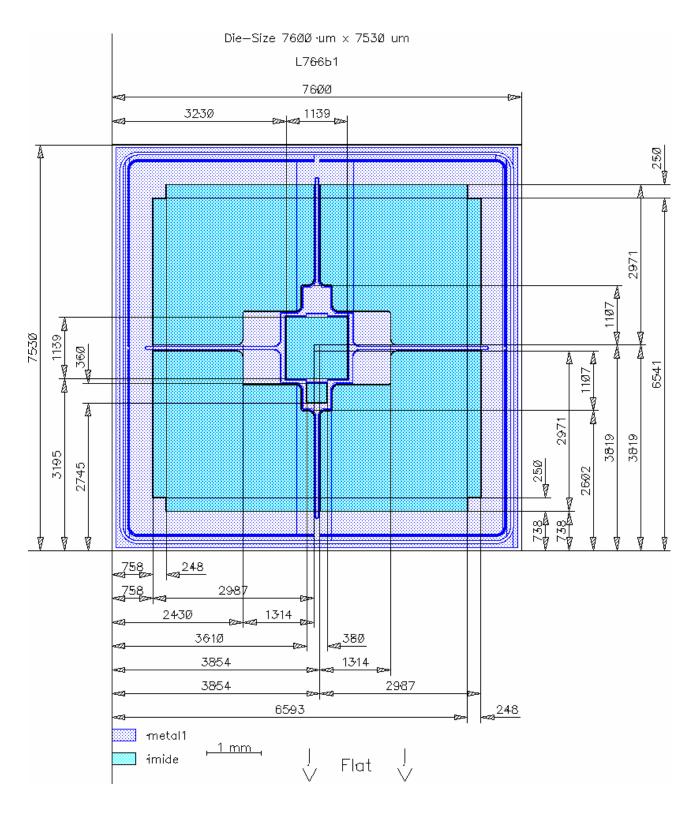
SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol Conditi	Conditions 1)	Value			Unit
		Conditions	min.	typ.	max.	
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j =125°C		0.09		μs
Rise time	t _r	V _{CC} =600V, I _C =50A, V _{GE} =-15/15V,		0.05		
Turn-off delay time	$t_{d(off)}$	$V_{\text{GE}} = -15/15 \text{V},$		0.52		
Fall time	t_{f}	$R_{\rm G}$ = 18 Ω		0.09		

¹⁾ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING:





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FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet	tbd					
DESCRIPTION:						
AQL 0,65 for visual inspection according to failure catalog						
Electrostatic Discharge Sensitive Device according to MIL-STD 883						
Test-Normen Villach/Prüffeld						

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